# **MOSFET** - Power, Single, N-Channel, SO-8 FL 30 V, 93 A

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

# **Applications**

• CPU Power Delivery, DC-DC Converters

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

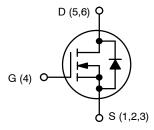
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Para	Parameter				Unit
Drain-to-Source Vo	tage		$V_{DSS}$	30	V
Gate-to-Source Vol	tage		$V_{GS}$	±20	V
Continuous Drain Current R <sub>θJA</sub>		T <sub>A</sub> = 25°C	I <sub>D</sub>	21.8	Α
(Note 1)		$T_A = 100^{\circ}C$		13.8	
Power Dissipation R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.63	W
Continuous Drain Current R <sub>θJA</sub> ≤		T <sub>A</sub> = 25°C	I <sub>D</sub>	40	Α
10 s (Note 1)		T <sub>A</sub> = 100°C		25	
Power Dissipation $R_{\theta JA} \le 10 \text{ s}$ (Note 1)	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	8.7	W
Continuous Drain	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	13	Α
Current R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 100°C		8.2	
Power Dissipation R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.93	W
Continuous Drain Current R <sub>θJC</sub>		T <sub>C</sub> = 25°C	I <sub>D</sub>	93	Α
(Note 1)		T <sub>C</sub> = 85°C		59	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	48	W
Pulsed Drain Current	T <sub>A</sub> = 25°	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	275	Α
Current Limited by P	ackage	T <sub>A</sub> = 25°C	I <sub>Dmax</sub>	100	Α
Operating Junction a Temperature	Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	–55 to +150	°C
Source Current (Bod	y Diode)		I <sub>S</sub>	44	Α
Drain to Source DV/I	DT		dV/d <sub>t</sub>	6	V/ns



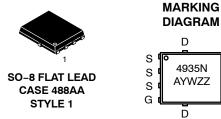
# ON Semiconductor®

## http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
30 V	3.2 mΩ @ 10 V	00.4	
	4.2 mΩ @ 4.5 V	93 A	



**N-CHANNEL MOSFET** 



= Assembly Location Α

D

= Year W = Work Week ZZ = Lot Traceability

## ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTMFS4935NT1G	SO-8 FL	1500 /
NTMFS4935NCT1G	(Pb-Free)	Tape & Reel
NTMFS4935NT3G	SO-8 FL	5000 /
NTMFS4935NCT3G	(Pb-Free)	Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy $T_J$ = 25°C, $V_{DD}$ = 24 V, $V_{GS}$ = 10 V, $I_L$ = 47 $A_{pk}$ , $L$ = 0.1 mH, $R_G$ = 25 $\Omega$	E <sub>AS</sub>	110	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	$T_L$	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface—mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface—mounted on FR4 board using the minimum recommended pad size.

# THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.6	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47.5	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	134.8	°C/VV
Junction-to-Ambient – (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	14.4	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

# FLECTRICAL CHARACTERISTICS /T.

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•			•	•	•	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	$V_{GS}$ = 0 V, $I_{D(aval)}$ = 19.5 A, $T_{case}$ = 25°C, $t_{transient}$ = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				15		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	
		$V_{DS} = 24 \text{ V}$	T <sub>J</sub> = 125°C			10	ο μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	<sub>S</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.2	1.63	2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		2.7	3.2	
			I <sub>D</sub> = 15 A		2.7		1
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		3.7	4.2	mΩ
			I <sub>D</sub> = 15 A		3.7		
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 1.5 V, I	<sub>D</sub> = 15 A		32		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C <sub>ISS</sub>				3579	4850	
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			1264	1710	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				39	59	
Capacitance Ratio	C <sub>RSS</sub> / C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MH	lz, V <sub>DS</sub> = 15 V		0.011	0.022	
Total Gate Charge	Q <sub>G(TOT)</sub>				22		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V 45.V.V	45.\\.\. 00.\		5.6		nC
Gate-to-Source Charge	$Q_{GS}$	$V_{GS}$ = 4.5 V, $V_{DS}$ =	15 V; I <sub>D</sub> = 30 A		10.2		
Gate-to-Drain Charge	$Q_{GD}$				3.0		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> =	15 V; I <sub>D</sub> = 30 A		49.4		nC
SWITCHING CHARACTERISTICS (Note 6)							
Turn-On Delay Time	t <sub>d(ON)</sub>				16.3		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V. V <sub>F</sub>	ns = 15 V,		20		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 4.5 V, $V_{D}$ $I_{D}$ = 15 A, $R_{G}$	= 3.0 Ω		27.5		ns
	1					ì	1

Fall Time

5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
6. Switching characteristics are independent of operating junction temperatures.

6.6

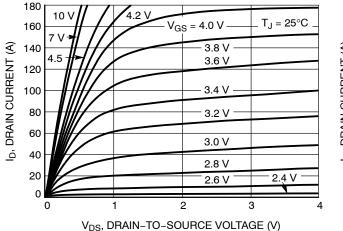
# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 6)						
Turn-On Delay Time	t <sub>d(ON)</sub>				11.2		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			18.7		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 15 A, R_G$	$_{\rm G} = 3.0 \ \Omega$		28.3		ns
Fall Time	t <sub>f</sub>				12.1		
DRAIN-SOURCE DIODE CHARACTI	ERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.85	1.1	
		I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.72		\ \
Reverse Recovery Time	t <sub>RR</sub>		•		44.4		
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 30 A			21.6		ns
Discharge Time	t <sub>b</sub>				22.8		
Reverse Recovery Charge	$Q_{RR}$				45		nC
PACKAGE PARASITIC VALUES				-			
Source Inductance	L <sub>S</sub>				0.65		nH
Drain Inductance	L <sub>D</sub>	т от			0.005		nΗ
Gate Inductance	L <sub>G</sub>	T <sub>A</sub> = 25°C			1.84		nΗ
Gate Resistance	$R_{G}$				1.1	1.4	Ω

<sup>5.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**

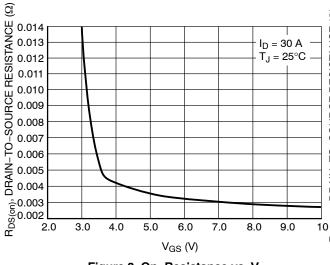
160



140  $V_{DS} = 10 V$ <sub>D</sub>, DRAIN CURRENT (A) 120 100 80  $T_J = 25^{\circ}C$ 60 40  $T_J = 125^{\circ}$ 20  $T_J = -55^{\circ}C$ 0 1.0 1.5 2.0 2.5 3.0 3.5 4.0 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 2. Transfer Characteristics

Figure 1. On-Region Characteristics



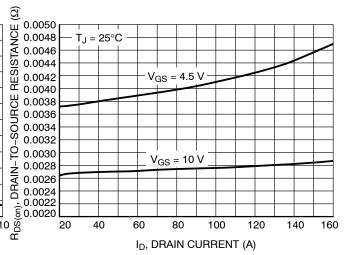
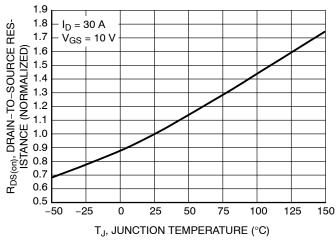


Figure 3. On-Resistance vs. V<sub>GS</sub>





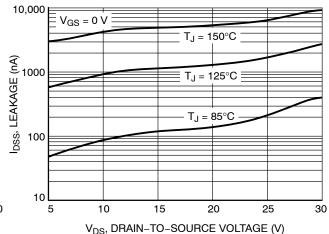


Figure 5. On-Resistance Variation with **Temperature** 

Figure 6. Drain-to-Source Leakage Current vs. Voltage

### **TYPICAL CHARACTERISTICS**

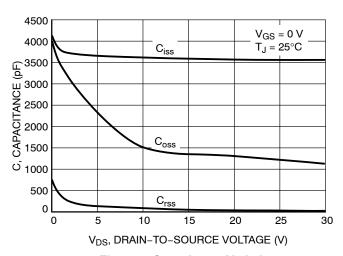


Figure 7. Capacitance Variation

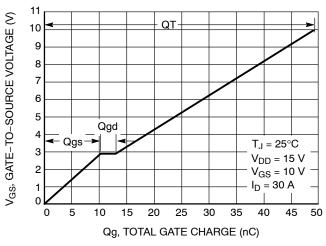


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

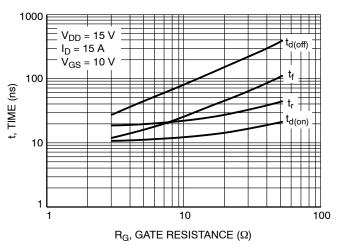


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

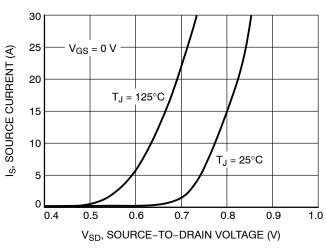


Figure 10. Diode Forward Voltage vs. Current

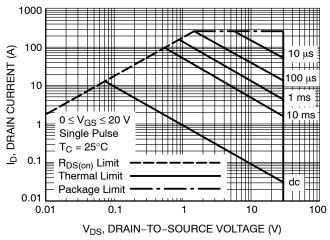


Figure 11. Maximum Rated Forward Biased Safe Operating Area

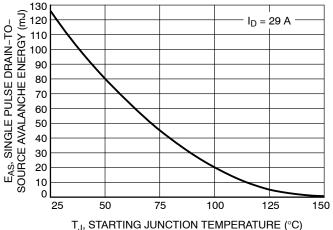


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

# **TYPICAL CHARACTERISTICS**

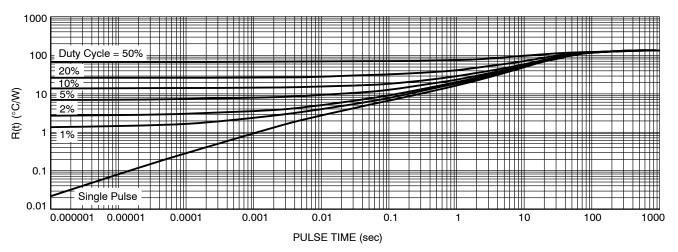


Figure 13. Thermal Response

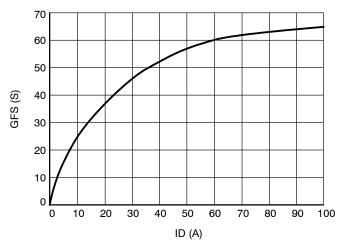


Figure 14. GFS vs. ID





0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N** 

# **DATE 25 JUN 2018**

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC	)		
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40 3.8			
θ	0 °		12 °		

## **GENERIC MARKING DIAGRAM\***

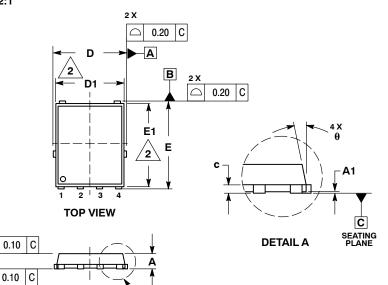


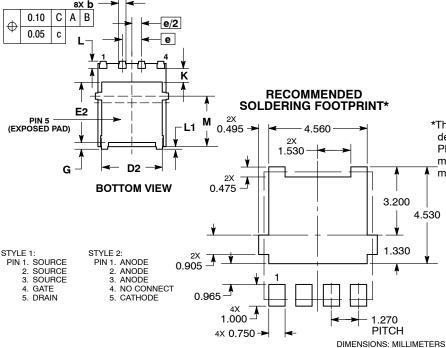
XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL** A

\*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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ſ	DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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